Application/Control No. Applicant(s)/Patent Under Reexamination 10/796,672 KIM ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 2815 Matthew Landau **U.S. PATENT DOCUMENTS** Date **Document Number** Name Classification Country Code-Number-Kind Code MM-YYYY 01-2003 US-2003/0001179 Takeuchi, Masahiko 257/296 Α US-В US-С US-D US-Ε US-F US-G US-Н US-US-US-K ÚS-US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W Х

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